查询U2391B供应商 **EMIC** Semiconducto

Quartz Controlled Pulse Generator

Description

The monolithic integrated bipolar circuit, U2391B, is designed as a quartz controlled pulse generator. The tristate input enables the selection of different pulse period durations. The internal switch-on monitoring

Features

- Standard quartz $f_{osc} = 32.768 \text{ kHz}$
- Minimum operating voltage 4.5 V/1.5 mA
- Pulse width, $t_p = 31.25$ ms
- Power stage with current limitation: . typical 150 mA
- Tristate period selection: 1/36/60 s
- Reset and disable possibility
- Operation with $C \ge 33$ pF, as operational time counter possible
- Minimum dimensions due to SO-case

Block Diagram

achieves the start up of the IC when the power-on occurs. The output pulse can supply a drive signal upto 150 mA, WWW.DZSC.COM which is short circuit protected.

U2391B

Application

Operational time counter

Case: SO8







U2391B

Pin Description

Pin	Symbol	Function
1	Period	Period selection input
2	GND	Ground
3	Output	Output control pulse
4	Contr.	Control input
5,6	Osc.	Quartz-oscillator input
7	Test	Test logic input/output
8	Vs	Supply voltage

Description

Pin 1, Period Selection Logic

Period selection at F	Pin 1 is as follows
Pin $1 = $ open,	$\tau = 36 \text{ s}$
Pin 1 = ground	$\tau = 1 s$
Pin $1 = V_S$ (Pin 8),	$\tau = 60 \text{ s}$

Pin 2, Ground

Pin 3, Output Stage

Output stage, being short circuit protected is limited to a current value of typical 150 mA. Apart from it, there is a voltage limitation which controls the power stage at the rate of $V_3 \ge 28.8$ to 32 V and serves as an active Z-diode. Output pulse width is 31.25 ms when quartz frequency is 32.768 kHz. It is independent of the selected period.

Pin 4, Control Logic

- Counting delay is typ 1.5 s (maximum 8 s) when Pin 4 is open and V_S is switched on.
- Programmable residual divider τ ≥ 1 s is reseated if Pin 4 is connected to Pin 8. This results in an absolute tolerance, at the start across "Reset/End" to be ≤ 1 s.
- Clock input to the 2⁷ divider is inhibited, if Pin 4 is connected to the ground (Pin 2). Absolute tolerance for every interruption is ≤ 0.488 ms.

• An interruption is ignored (Pin $4 = \perp$) during the output pulse time.

Figure 2. Pinning

ΓΕΜΙΟ

Semiconductor

Vs

Test

Osc.

Osc.

9611805

8

7

6

5

• When Pin 4 is switched to V_S during the output pulse time – this output pulse will be reseated.

Pin 5, 6 Quartz-Oscillator Input

The propagated period time selection is based on circuit with a low cost clock quartz of 32.768 kHz.

Pin 7, Test Logic, Figure 2, 3

To test the circuit in a reasonable time, it is possible to control the divider ($f_0 = 16 \text{ Hz}$) at Pin 7 as well as to feed in a higher frequency to the programmed residual counter ($f_i \le 2 \text{ kHz}$).

Pin 8, Supply Voltage

Period

GND

Output

Contr.

1

2

3

4

An operating voltage of 4.5 V is necessary for the functioning of the circuit, although an internal switch-on monitoring allows it to operate with a voltage of 3.6 V. This means that there is sufficient reliability for the performance of the circuit.

The circuit is designed for $12 \text{ V} \pm 10\%$ with internal supply voltage limitation of typical 15 V. In case of higher voltages there is a need of a series resistance and buffer capacitance as shown in figure 1.

Preliminary Information

Absolute Maximum Ratings

Reference point Pin 2, unless otherwise specified

Parameters		Symbol	Value	Unit
Supply current	Pin 8	IS	30	mA
$t \le 10 \mu s$		i _s	150	
Supply voltage	Pin 8	Vs	13.2	V
without series resistance				
Voltages				
Selection logic	Pin 1	V1	0 to V _S	V
Control logic	Pin 4	V_4	0 to V_S	
Output stage, without				
protection circuit	Pin 3	V3	28.8	
Currents				
Test logic	Pin 7	I ₇	± 100	μΑ
Oscillator	Pin 5, 6	I _{osc}	± 100	μΑ
Output stage $t \le 1 \text{ ms}$	Pin 3	I ₃	300	mA
Power dissipation				
$T_{amb} = 45^{\circ}C$		P _{tot}	270	mW
$T_{amb} = 85^{\circ}C$			135	
Storage temperature range		T _{stg}	-40 to +125	°C
Ambient temperature range		T _{amb}	-20 to +100	°C
Junction temperature		Tj	125	°C

Electrical Characteristics

Parameters	Test Conditions / Pins	Symbol	Min.	Тур.	Max.	Unit
DC supply currents	$V_8 = 5 V$ Pin 8	IS		1.2	1.5	mA
	$V_8 = 12 V$				2	
Minimum supply voltage	Pin 8	VS	4.5			V
Supply voltage limitation	$I_8 = 3 \text{ mA}$ Pin 8	Vs	13.2	15	16.3	V
	$I_8 = 30 \text{ mA}$				17.2	
Voltage monitoring	Pin 8					
Turn-on threshold		V _{TON}		3.6		V
Turn-off threshold		V _{TOFF}		2.4		V
Temperature coefficient		-TC		0.33		%/K
Selection logic	$Pin \ 1 = \bot (1 \ s)$	I ₁		6		μΑ
	Pin $1 = +$ (60 s)	$-I_1$		6		
Control logic	Pin $4 = 0$ V (Interrupt)	I4		45		μΑ
_	Pin 4 = 5 V (Reset)	$-I_4$		135		-
	Reset current	$-I_4$	65		1500	
Oscillator $f_{osc} = 32768 \text{ Hz}, C_{osc} \ge 33 \text{ pF}$						
Operating current	Pin 5, 6	-Iosc		20		μA
Build-up time		ton		1.5	8	S

U2391B

TEMIC	ץ ר
Semiconductor	s

Parameters	Test Conditions / Pins	Symbol	Min.	Тур.	Max.	Unit
Output stage	Pin 3					
Saturation voltages	$-I_{O} = 100 \text{ mA}, V_{S} = 12 \text{ V}$ $-I_{O} = 75 \text{ mA}, V_{S} = 12 \text{ V}$	Vo			0.5 0.5	V
Current limitation	$V_3 = 2 V$	-I _O	100		220	mA
Output pulse width	f _{osc} = 32768 Hz	tp		31.25		ms
Voltage limitation	$-I_O = 1 \text{ mA}$	V _{limit}	28.8		33	V
Reserve current	$V_3 = 12 V$	I _{O(R)}			10	μΑ
Drive current	$V_8 = 5 V$ Pin 8	ΔI_8		4		mA
$(\Delta I_8 \text{ during } t_p)$	$V_8 = 12 V$			10		

Test Circuit



Figure 3. 16 Hz Test



Figure 4. Programmed residual counter f_i = 2 kHz (Test clock)



Applications



Figure 5. Standard circuit for V_S = 4.75 to 14 V, without reset and interruption Cycle duration selected by Pin 1



Figure 6. $V_S = 24 V \pm 20\%$ with reset and interrupt switch, Cycle time $\tau = 60$ sec.

U2391B



Dimensions in mm

Package: SO8



Ozone Depleting Substances Policy Statement

It is the policy of TEMIC TELEFUNKEN microelectronic GmbH to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice. Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use TEMIC products for any unintended or unauthorized application, the buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

TEMIC TELEFUNKEN microelectronic GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany Telephone: 49 (0)7131 67 2831, Fax number: 49 (0)7131 67 2423